

Vacancy cluster growth and thermal recovery in hydrogen-irradiated tungsten

M. Zibrov^{a,b,c,*}, W. Egger^d, J. Heikinheimo^{e,f}, M. Mayer^a, F. Tuomisto^{e,g}

^aMax Planck Institute for Plasma Physics, 85748 Garching, Germany

^bPhysik-Department E28, Technische Universität München, 85748 Garching, Germany

^cDepartment of Applied Physics, Ghent University, 9000 Ghent, Belgium

^dInstitut für Angewandte Physik und Messtechnik, Universität der Bundeswehr München, 85577 Neubiberg, Germany

^eDepartment of Applied Physics, Aalto University, P.O. Box 15100 FI-00076 Aalto, Finland

^fVTT Technical Research Centre of Finland Ltd, Nuclear Safety, P.O. Box 1000 FI-02044 VTT, Finland

^gDepartment of Physics and Helsinki Institute of Physics, University of Helsinki, P.O. Box 43, FI-00014 Helsinki, Finland

Abstract

The thermal evolution of vacancies and vacancy clusters in tungsten (W) has been studied. W (100) single crystals were irradiated with 200 keV hydrogen (H) ions to a low damage level (5.8×10^{-3} dpa) at 290 K and then annealed at temperatures in the range of 500–1800 K. The resulting defects were characterized by positron annihilation lifetime spectroscopy (PALS) and positron annihilation Doppler broadening spectroscopy (DBS). Annealing at 700 K resulted in the formation of clusters containing 10–15 vacancies, while at 800 K and higher temperatures clusters containing about 20 vacancies or more were formed. Reduction of the defect concentration likely accompanied by further coarsening of the clusters started at 1300 K and ended at 1800 K with the complete defect recovery. The determined cluster sizes at 700 K and 800 K were larger than the estimated minimum cluster sizes that are thermally stable at these temperatures, indicating that the migration and ensuing coalescence of small clusters plays an important role in cluster growth.

*Corresponding author

Email address: Mikhail.Zibrov@ipp.mpg.de (M. Zibrov)

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1. Introduction

One of the key issues on the way of the development of fusion power plants is the selection of proper plasma-facing materials (PFMs) [1]. Due to its high melting temperature, high thermal conductivity, high sputtering threshold, and relatively low long-term activation after neutron irradiation, tungsten (W) is nowadays considered as one of the most promising materials [2, 3]. It was chosen as the divertor material for the international experimental fusion reactor ITER, and is also considered as the divertor and the first wall material for future fusion devices, such as a demonstration fusion reactor (DEMO). In fusion reactors with a “burning” deuterium-tritium plasma, PFMs are subjected to intense fluxes of 14 MeV neutrons that introduce radiation defects (vacancies and interstitial atoms, vacancy clusters, dislocation loops, etc.) through the whole material thickness. Neutrons also cause material transmutation, resulting in its activation and production of both hydrogen (H) and helium (He). This alters the thermo-mechanical properties of the materials (degradation of thermal conductivity, embrittlement, swelling, and irradiation creep). Radiation defects serve as trapping sites for H isotopes, hence, their presence can significantly increase the tritium inventory in PFMs. These issues govern the possibility of a safe and economically feasible operation of a fusion power plant.

PFMs will be operated at elevated temperatures, resulting in a thermal evolution of the radiation defects [2, 3, 4, 5]. Vacancies and interstitials can migrate by thermally activated diffusion and annihilate either by recombining with each other or at extended sinks (free surfaces, grain boundaries, and dislocations). They can also agglomerate into more stable extended defects, such as vacancy clusters and dislocation loops. Vacancies, interstitials, and their clusters can also trap impurities (e.g., H, C), which may reduce their mobility and also prevent their annihilation. There are five major temperature regions of defect annealing (recovery) in metals [4, 5]. They are linked either with the mobility of certain defect types or with the dissociation of defect clusters and defect-impurity complexes.

To unravel the mechanisms governing each recovery stage, post-irradiation isochronal annealing experiments are typically carried out. The summary of

these studies for W can be found in [4, 6]. Although the reported temperature ranges of the various stages have some scatter, it should be stressed that these temperatures are not universal physical quantities since they depend on the used annealing scheme and on the concentration of defects, defect sinks, and impurities [4, 7]. The corresponding fundamental quantities are the activation energies for the respective processes. The annealing studies of neutron-irradiated W allowed the characteristic temperatures and activation energies of different stages to be identified, but the interpretation of the results is complicated due to the presence of several types of radiation defects in the samples. Basic studies of the annealing stages of the simplest type of radiation defect, Frenkel pairs (vacancies and interstitials) introduced by MeV electron irradiation, have also been carried out. However, most of them were performed by measuring the electrical resistivity recovery which is sensitive to the presence of defects, but the corresponding changes of the defect structure cannot be identified. Direct observations using transmission electron microscopy (TEM) are possible only for defect clusters larger than about 1 nm.

Positron annihilation spectroscopy (PAS) is sensitive to open-volume defects with sizes ranging from single vacancies to TEM-visible cavities [8]. The existing positron annihilation Doppler broadening spectroscopy (DBS) studies of the recovery of (predominantly) Frenkel pairs in W introduced by light ion (H, He) irradiation to low damage levels covered a broad temperature range (423–1900 K) [7, 9, 10, 11]. They were able to elucidate vacancy agglomeration in clusters during the recovery stage III, further coarsening of clusters at higher temperatures, and eventual recovery of the defects. However, the sizes of formed vacancy clusters could not be determined from DBS measurements. Positron annihilation lifetime spectroscopy (PALS) is capable of determining sizes of small vacancy clusters. However, in the studies by Sato et al. [12] and Heikinheimo et al. [13] the damage levels were too low to observe vacancy cluster formation. It has been detected by de Vries [14], but the measurements were carried only up to 900 K. Ogorodnikova et al. [15] has also observed vacancy clustering, but the complete defect recovery took place already at 1173 K, indicating that the defect concentration was not sufficiently high to observe the high-temperature recovery stage V previously observed by DBS [7, 9, 11].

This paper reports on the thermal evolution of vacancies and vacancy clusters in W in a wide range of temperatures (500–1800 K) investigated using both DBS and PALS techniques. Since the recovery stages I and II

in W related with the mobility of self-interstitials and their complexes take place already below room temperature [4, 13], they are not relevant for fusion applications and are not examined in the present study. To minimise the impact of intrinsic defects in the material, such as impurities, dislocations, and grain boundaries, high-purity single crystalline W samples are used. Mostly Frenkel pairs are introduced as primary defects in the specimens via irradiation with 200 keV H ions to a low damage level (5.8×10^{-3} dpa). In this case the damaged zone is about 1 μm thick, which makes the surface a dominant and well-defined sink for the defects.

2. Experimental details

2.1. Sample preparation

The specimens were prepared from a high-purity single crystalline W rod grown along the $\langle 100 \rangle$ direction by electron-beam floating zone melting at the Institute of Solid State Physics (Chernogolovka, Russia) [16, 17]. The stated accuracy of the rod orientation is within 2° . The dislocation density in the as-grown crystals is in the range of 10^9 – 10^{11} m^{-2} and most of the dislocations are arranged in walls, forming low-angle grain boundaries with a mean grain size around 500 μm [16, 17]. The major stated impurities are (in 10^{-6} at. fr.): C (< 15.3), N (< 7.9), O (< 5.8), Na (< 2.4), Si (< 2.0), P (< 1.8), and S (< 1.7). The samples with (100) crystal surfaces were cut by spark erosion from the rod to $10 \times 10 \times 1$ mm^3 . The residue from the cutting was removed by grinding of the samples with a set of SiC sandpapers with decreasing grit sizes (up to P4000). Then they were electrochemically polished to a mirror-like finish in a 1.5 wt.% NaOH aqueous solution at a voltage of 19 V. The samples were successively cleaned in an ultrasonic bath with acetone, isopropanol, and a high-purity acetone and then rinsed in deionized water. Analysis of two specimens after cutting and polishing by the Laue X-ray diffraction method showed that their surface normal is within 4° of the $\langle 100 \rangle$ direction. To reduce the possible spatial non-homogeneity of the microstructure and remove gaseous impurities, the specimens were first degassed at a temperature near 1350 K for 20 min and then annealed at about 2550–2600 K for 3 min (as a series of 30 s annealings) at a base pressure below 10^{-6} Pa.

2.2. Ion irradiation

In order to introduce mainly Frenkel pairs as primary defects, the samples were irradiated by 200 keV H ions in the implantation chamber connected to the 3 MV tandem accelerator at IPP [18]. The residual pressure in the chamber is below 10^{-5} Pa. The samples are clamped to a water-cooled copper (Cu) holder by using molybdenum masks with an opening area of 8×8 mm². The temperature of the holder is measured by an attached K-type thermocouple and is kept close to 290 K. In order to obtain a laterally homogeneous damaged area, the incident beam (2 mm FWHM) is scanned over the whole sample surface. The incident ion flux is controlled during irradiation by four small Faraday cups located at the corners of a water-cooled Cu diaphragm placed in front of the sample holder. The irradiations are carried out at normal ion incidence and the ion flux is around 10^{16} H/m²s. The samples were irradiated to a fluence of 10^{20} H/m². The depth distribution of the radiation damage (expressed in displacements per atom – dpa) is calculated in SRIM 2013.00 [19] using the “quick” calculation of damage option based on the modified Kinchin-Pease (NRT) model, as recommended by Stoller et al. [20]. The displacement threshold energy of 90 eV [21] is used and the lattice binding energy is set to 0 eV. Displacements created both by the incident ions and recoils (listed in the `vacancy.txt` output file) are taken into account. The calculations predict that most of the displacements (78 %) are produced directly by the incident ions, which means that only small collision cascades producing mainly Frenkel pairs as primary defects are initiated [22, 23]. The resulting damage profile is non-uniform with a pronounced maximum (Bragg peak) of 5.8×10^{-3} dpa located at a depth of 700 nm, as illustrated in Fig. 1. This damage level should be low enough to minimise the formation of complex defect structures due to the overlap of the produced defects [22]. During the irradiation H ions also get implanted into the material, as shown in Fig. 1. In a fusion reactor H isotopes will also be present in W components due to their implantation from plasma and as a product of (n, p) transmutation reactions.

2.3. Post-irradiation annealing

After the irradiation, the samples were annealed for 15 min in vacuum at temperatures in the range of 500–1800 K. A new sample was used for every annealing temperature. Annealing at 500–1300 K was done in a setup where a sample is located in a quartz tube evacuated to about 10^{-6} Pa

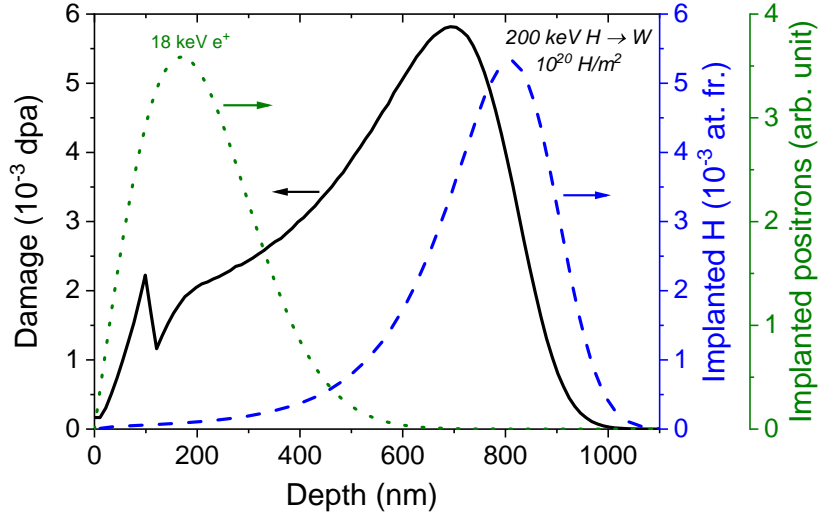


Figure 1: The damage profile created by 200 keV H ions in W (solid line) and the H implantation profile (dashed line) calculated using SRIM. The fluence is 10^{20} H/m². Note that the peak at a depth of 93 nm in the damage profile is an artefact due to the free flight path concept of SRIM. The implantation profile of 18 keV positrons in W (dotted line) calculated according to the Makhov distribution is also shown.

and is heated by radiation from an external tube furnace. The oven is pre-heated to a certain temperature and then quickly pushed over the tube. At the end of the heating cycle, the furnace is rapidly retracted from the tube. The sample temperature versus the oven temperature is calibrated in independent experiments by a K-type thermocouple spot-welded to the sample. The time required to reach the desired temperature decreases with increasing temperature: it takes around 40 min to heat the sample from room temperature to 500 K, while only about 2.5 min are necessary to achieve 1300 K. Annealing at 1400–1800 K was done in a different setup where the samples are located in U-shaped cradles made of W and heated by 3 keV electron bombardment from the side opposite to the irradiated side at a base pressure below 10^{-6} Pa. The sample temperature is measured with a disappearing-filament pyrometer. The real sample temperature is calculated from the measured brightness temperature using the temperature-dependent W spectral emissivity taken from [24]. The sample temperature was ramped to the desired one within a few minutes. The variations of ramp rates between different samples is not considered important.

2.4. Positron annihilation spectroscopy

Characterization of open-volume defects in the samples, such as vacancies and vacancy clusters, was carried out using two positron annihilation techniques, Doppler broadening spectroscopy (DBS) and positron annihilation lifetime spectroscopy (PALS) [8, 25]. The same samples were measured by both techniques. These methods are based on the fact that positrons implanted into a material exhibit a certain lifetime (before the annihilation with an electron) that depends on the electron density of the medium. Implanted positrons can get trapped at open-volume defects in the lattice. The reduced electron density at such defects increases the lifetime of the positrons. Density functional theory (DFT) calculations indicate that positron lifetimes in vacancy clusters in W increase with cluster size for clusters containing up to 20 vacancies and then tend to saturate for larger clusters [26]. In addition, the momentum of the annihilating electron creates a Doppler shift in the energy of the two 511 keV annihilation γ -quanta. The lack of high-momentum core electrons at open-volume defects reduces the average Doppler shift as compared with the defect-free material, i.e., narrows the annihilation line. Hence, γ -quanta carry information about the environment of the annihilating positron.

The DBS measurements were carried out using a monoenergetic positron beam produced by a moderated ^{22}Na source (Aalto University). To perform depth profiling of the defects, the incident positron energy is varied in the range of 0.5–25 keV corresponding to mean implantation depths in W in the range of 0.7–360 nm and a maximum information depth of 700 nm [25]. A high-purity germanium detector with good energy resolution (FWHM = 1.2 keV at 511 keV) and Gaussian response is used for the Doppler broadening recordings. The number of collected counts is 10^6 . The broadening is characterized with the annihilation parameters S and W that represent the fraction of annihilations with low-momentum and high-momentum electrons, respectively. The S parameter is defined as the number of counts in the central region of the annihilation line (0–0.41 a.u.; 0–0.76 keV) divided by the total number of counts in the annihilation line. W is defined as the counts in the wing regions of the annihilation line (1.6–4.0 a.u.; 2.9–7.5 keV) divided by the total number of counts in the annihilation line. The presence of open-volume defects in the material results in an increase of S and a respective decrease of the W parameter. Furthermore, the S - W correlation plots can be used to identify the defect types [25]. The positron diffusion lengths in the samples are determined by analysing the measured $S(E)$ dependences

using VEPFIT [27].

The PALS measurements were carried out using the pulsed low-energy positron beam system (PLEPS) [28, 29] at the NEPOMUC positron source (FRM II reactor). The system utilizes a pulsed positron beam (150 ps FWHM, frequency 50 MHz) with high intensity and a low background. The used positron implantation energy is 18 keV. The positron implantation profile at this energy is shown in Fig. 1. The γ -quanta are detected with a photomultiplier coupled to a BaF₂ scintillator and the time between the annihilation and the following pulse is recorded. The total number of events collected in each lifetime spectrum is 4×10^6 . The instrumental time resolution function $R(t)$, which can be described by a sum of three-four shifted Gaussian functions, is determined with a p-type SiC reference sample and has a FWHM of 230–250 ps. The measured data are analysed using POSWIN (a modified version of PositronFit [30]) where the model function is fitted to an experimental spectrum. The model function is described by a sum of exponential decays convoluted with $R(t)$ and overlaid on a constant background BG : $R(t) * \sum_i (I_i/\tau_i) \exp(-t/\tau_i) + BG$, where τ_i and I_i ($\sum_i I_i = 1$) represent positron lifetimes and their relative intensities, respectively. Apart from the τ_1 component due to positrons annihilating in the defect-free bulk, each defect type gives rise to a characteristic lifetime τ_i ($i = 2, 3, \dots$) in a lifetime spectrum. I_i is a measure of the relative concentration of the defects associated with τ_i . Practically, components with lifetimes close to each other cannot be resolved. Therefore, the lifetime components extracted from experimental spectra can sometimes represent averaged “effective” values. In the present work the spectra were decomposed into three to four lifetime components with good variance ($\chi^2_\nu < 1.6$). The intensity of the fourth lifetime is always below 1%, therefore, it will be neglected in the discussion and the third lifetime will be always referred to as the longest lifetime. Although the decomposition of the spectra into lifetime components may be sometimes ambiguous due to the extreme sensitivity of exponential fits to noise in the data [31], the average positron lifetime $\tau_{av} = \sum_i I_i \tau_i$ representing the statistical mean of the lifetime distribution is almost insensitive to uncertainties of the decomposition.

3. Results and discussion

3.1. Qualitative analysis

The recorded positron lifetime spectra shown in Fig. 2 clearly demonstrate significant differences in the positron lifetimes, and, hence, in the defect structure of the samples after irradiation and subsequent annealing at various temperatures. To assess the reproducibility of the sample preparation procedures, two unirradiated and two as-irradiated specimens have been measured and in both cases the lifetime spectra of two samples are almost indistinguishable. To reduce the statistical scatter in the data, the averaged PALS results over two unirradiated and as-irradiated samples will be shown.

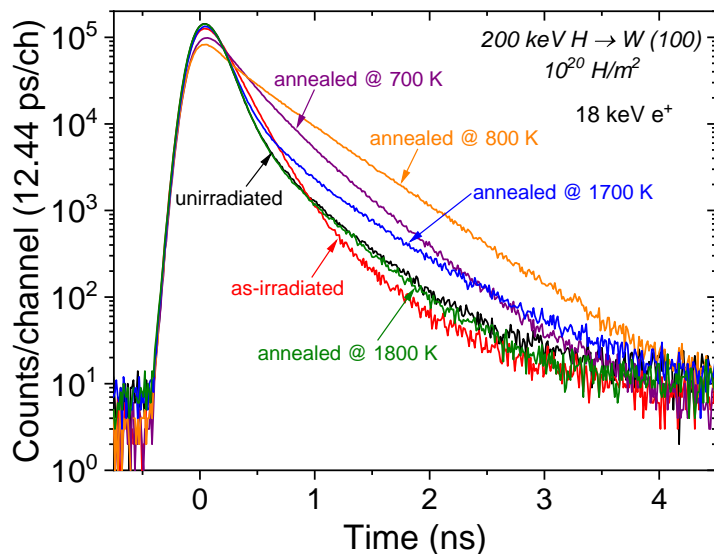


Figure 2: Positron lifetime spectra at 18 keV positron implantation energy for W (100) single crystals irradiated with 200 keV H ions to a fluence of 10^{20} H/m² and then annealed at various temperatures for 15 min.

A general idea about the evolution of the defect structure with annealing temperature can be obtained from the changes of the average positron lifetime τ_{av} and of the S parameter. These are shown in Fig. 3 for 18 keV positrons. Both τ_{av} and S demonstrate remarkably similar behaviour, which shows that they describe similar characteristics of the defects. An unirradiated sample has the lowest τ_{av} close to the typical defect-free bulk lifetime, indicating that the majority of the positrons annihilate from the delocalized

bulk state. Irradiation with 200 keV H ions increases the S parameter and τ_{av} to 156 ps, demonstrating introduction of mainly small open-volume defects. Post-irradiation annealing at 700 K and 800 K results in a sharp increase of τ_{av} and S , indicating trapping of positrons in large open-volume defects, such as vacancy clusters. Both parameters then weakly decrease after annealing at temperatures in the range of 900–1200 K. Starting from 1300 K both τ_{av} and S decrease considerably with increasing temperature. This can be attributed to progressive defect recovery. Eventually, after annealing at 1800 K both parameters are identical to those of the unirradiated sample, demonstrating complete removal of radiation defects.

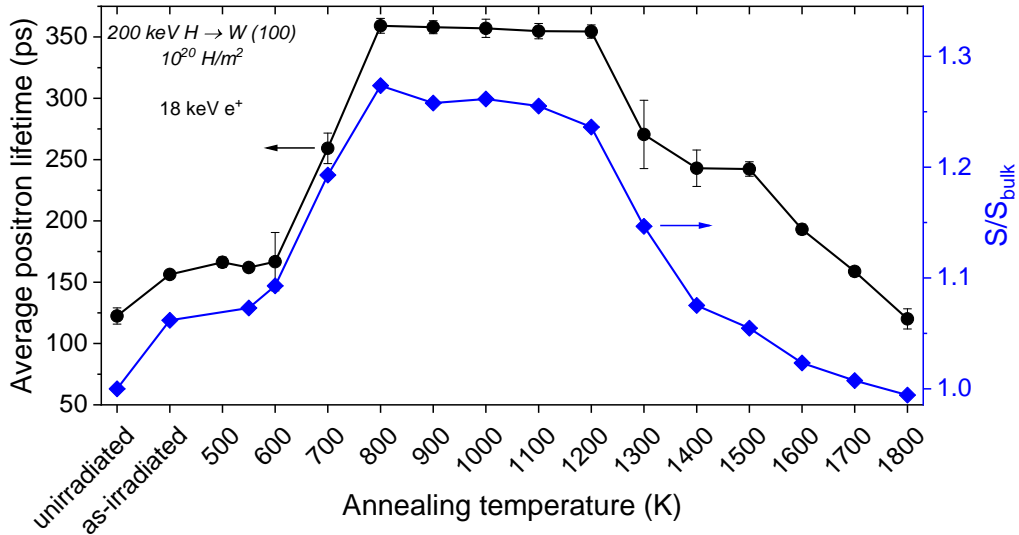


Figure 3: Average positron lifetime (τ_{av}) and low-momentum annihilation fraction (S) as function of annealing temperature for W (100) single crystals irradiated with 200 keV H ions to a fluence of 10^{20} H/m² and then annealed at various temperatures for 15 min. The positron implantation energy is 18 keV. For the unirradiated sample and the samples annealed at 1600 K, 1700 K, and 1800 K the corresponding bulk S parameter values are obtained from VEPFIT because of large positron diffusion lengths in the samples. The S parameter is normalized to the bulk value of the unirradiated sample (S_{bulk}) obtained from VEPFIT.

A similar temperature dependence of the S parameter is observed at positron implantation energies starting from about 12 keV (Fig. 4). At lower energies the S parameter is influenced by surface effects: the lower the implantation energy is, the higher is the probability for a positron to diffuse back to the surface where it can either annihilate or escape from the material.

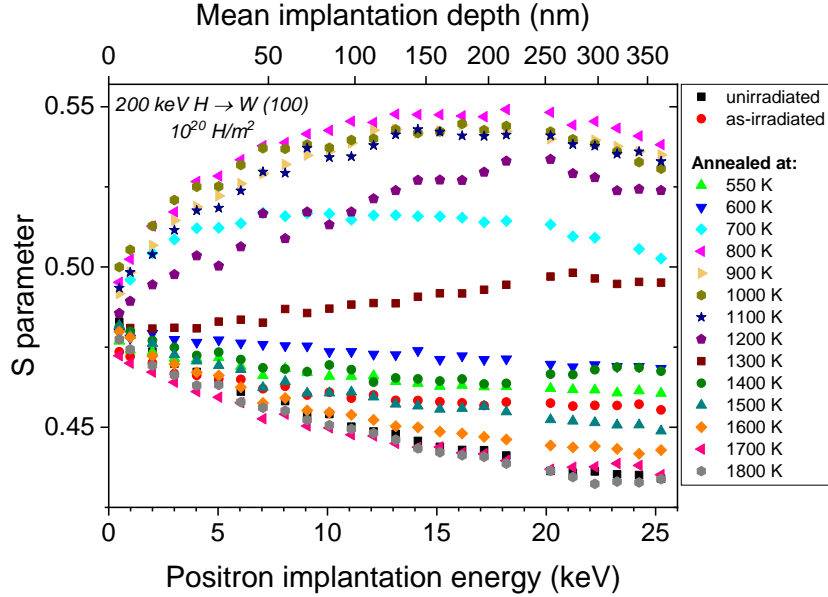


Figure 4: Low-momentum annihilation fraction (S) as function of the positron implantation energy in W (100) single crystals irradiated with 200 keV H ions to a fluence of 10^{20} H/m² and then annealed at various temperatures for 15 min. The top x -axis shows the corresponding mean positron implantation depth calculated according to the Makhov distribution.

3.2. Quantitative analysis

More detailed insight into the changes of the defect sizes and concentrations can be gained from the results of the decomposition of the positron lifetime spectra into components shown in Fig. 5. Thanks to the peak-to-background ratio in the spectra above 10^4 (Fig. 2) and no need in subtracting annihilations in the source, long lifetimes with even small intensities can be observed.

3.2.1. Reference material

Measuring the unirradiated samples using a conventional fast positron lifetime spectrometer yields a single lifetime of 110 ps, corresponding to the bulk lifetime in W (100–110 ps) [13, 26, 32, 33, 34, 35]. Spectra of unirradiated samples measured with 18 keV pulsed positron beam can be decomposed with a good variance into three lifetime components. The shortest lifetime (“reduced bulk lifetime”) comprises both the annihilation from the delocalized bulk state and disappearance from it by trapping at the surface (or

escaping from the material). DBS data shows that the positron diffusion length (before the annihilation) in the unirradiated sample is 96 nm, which is characteristic for a well-annealed W [11]. As the $S(E)$ profile of the unirradiated specimen has not reached the plateau even at 25 keV (Fig. 4), the fraction of positrons implanted with 18 keV that diffuse back to the surface is not negligible. Therefore, the longest positron lifetime near 350 ps should correspond to annihilation at the W surface. The reported positron lifetimes at metallic surfaces are lying in a very wide range of 350–600 ps [32, 36, 37]. The second lifetime is around 100 ps, corresponding to the defect-free (bulk) lifetime in W [13, 26, 32, 33, 34, 35].

3.2.2. Initial defect configuration

In the as-irradiated samples almost 80% of positrons are trapped in defects with a lifetime of 165 ps. This value is slightly lower than the reported positron lifetime in a single vacancy in W (180–200 ps) [11, 13, 14, 15, 26, 33, 34, 35, 38]. This can be due to the fact that the vacancies in the as-irradiated samples are (at least partly) filled with implanted H, which decreases the positron lifetime in them [14, 26, 38]. Neglecting the presence of other defect types, the fraction of positrons annihilating in these dominant defects can be estimated using the determined positron diffusion lengths in unirradiated ($L_{ref} = 96$ nm) and as-irradiated samples ($L_{irr} = 45$ nm) as $\eta_V = (L_{ref}^2 - L_{irr}^2)/L_{ref}^2 = 0.78$ [39]. It agrees well with the relative intensity of these defects in the lifetime spectra. Using the bulk relative S and W values for the as-irradiated sample, the bulk relative S_V and W_V values characteristic for the dominant defect type in the as-irradiated sample (presumably single vacancies) were obtained. Less than 5% of positrons in the as-irradiated samples annihilate in defects with a lifetime around 420 ps. Due to a smaller positron diffusion length in this sample (45 nm) and the fact that the respective $S(E)$ profile has already reached a plateau at 18 keV, the fraction of implanted positrons annihilating at the surface should be rather small. Consequently, the 420 ps component should mainly correspond to annihilation at vacancy clusters introduced during irradiation.

3.2.3. Defect behaviour during annealing

500-600 K. Post-irradiation annealing at temperatures in the range of 500–600 K results in a gradual increase of the second lifetime up to 195 ps. This value is within the range of reported positron lifetimes in an empty single vacancy in W. The value of the longest lifetime fluctuates around 420 ps,

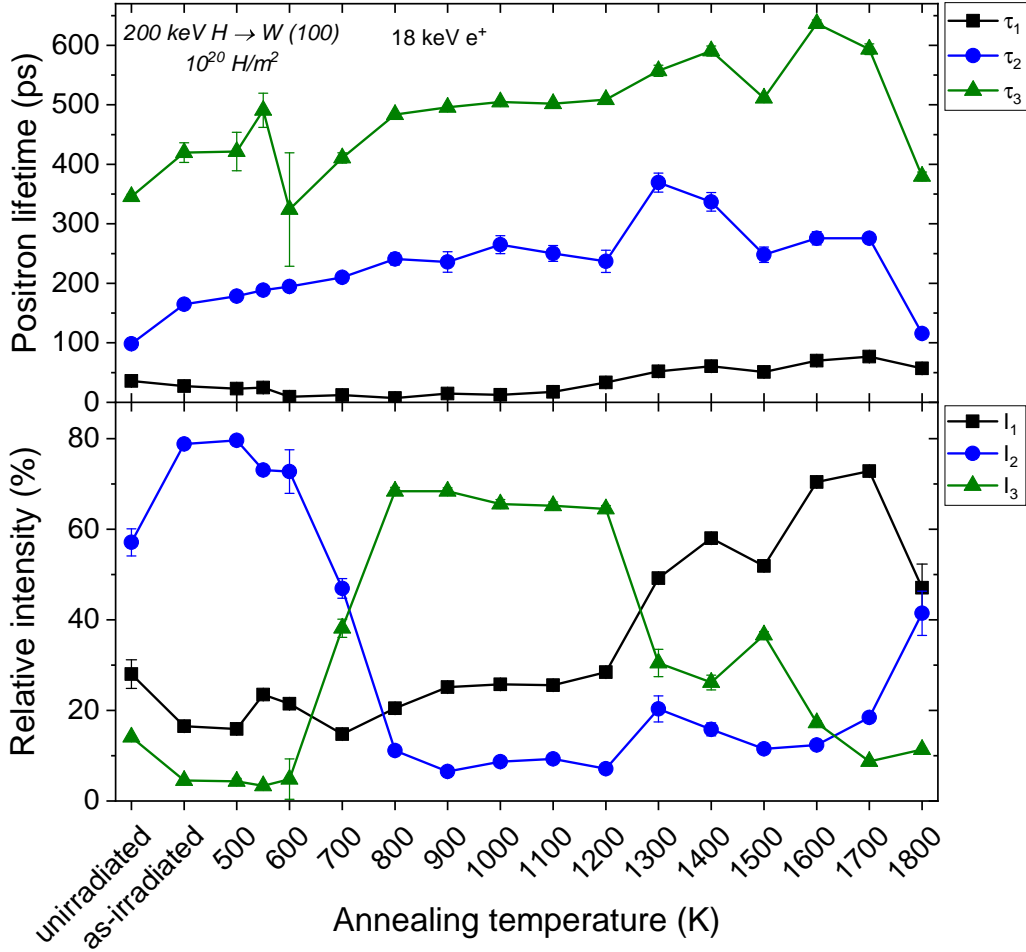


Figure 5: Positron lifetimes (upper panel) and their relative intensities (lower panel) as a function of annealing temperature for W (100) single crystals irradiated with 200 keV H ions to a fluence of 10^{20} H/m² and then annealed at various temperatures for 15 min. The positron implantation energy is 18 keV.

while its intensity stays within 5% indicating little changes in the structure of the existing vacancy clusters. In the S - W map shown in Fig. 6 the points corresponding to the as-irradiated sample and the samples annealed at 500–600 K are lying on the same line (1) connecting the bulk S - W value with the S_V - W_V value characteristic for the introduced defects (presumably single vacancies). This demonstrates that the nature of the defects does not change

significantly in this temperature range. The observed increase of the second lifetime is likely due to the release of trapped H from vacancies, which is known to occur in this temperature range [9, 14, 40].

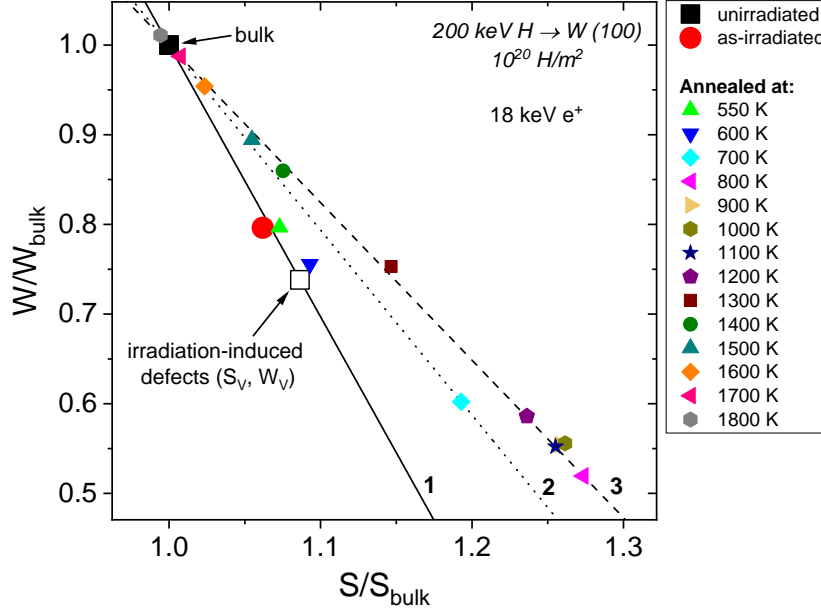


Figure 6: The S - W plot for W (100) single crystals irradiated with 200 keV H ions to a fluence of 10^{20} H/m² and then annealed at various temperatures for 15 min. The positron implantation energy is 18 keV. For the unirradiated sample and the samples annealed at 1600 K, 1700 K, and 1800 K the corresponding bulk S parameter values are obtained from VEPFIT because of large positron diffusion lengths in the samples. The shown parameters are normalized to the bulk values for the unirradiated sample (S_{bulk} , W_{bulk}) obtained from VEPFIT. The open square shows the calculated (S_V , W_V) for the dominant defect type in the as-irradiated sample (presumably single vacancy) based on the determined positron annihilation fraction η_V in them. The lines indicate positron annihilation at different defect types: (1) single vacancies, (2) medium-size vacancy clusters, (3) large vacancy clusters.

700-1200 K. Annealing at 700 K and 800 K results in a sharp increase of the intensity (and some increase of the value) of the longest lifetime component. This is accompanied by a decrease of the intensity of the second lifetime. After annealing at 700 K about half of the positrons annihilate in defects with a lifetime of 210 ps representing the mixture of annihilations at vacancies and small vacancy clusters; almost 40% of positrons annihilate at defects with a

lifetime of 410 ps corresponding to clusters containing 10–15 vacancies [26]. In the temperature range of 800–1200 K the lifetime components change only slightly. The dominant (around 65 %) longest lifetime close to 500 ps demonstrates the presence of clusters containing about 20 vacancies or more [26] and represents the theoretical limit of the positron lifetime in a cavity in a metal [33]. In the *S-W* plot (Fig. 6) it is clearly visible that the data from the sample annealed at 700 K does not lie on the line (1). After annealing at 800 K and higher temperatures, all data points lie close to the line (3). The smaller slope of line (3) as compared with (1) indicates the larger open volume associated with the dominant defects, in agreement with PALS results.

Despite the rather convincing results described above, their interpretation requires some care. It should be kept in mind that neither PALS nor DBS techniques are able to distinguish between the growth of vacancy clusters and H release from the vacancy clusters created during the irradiation as both processes increase the effective open volume [14, 26, 36]. The observed increase of the relative intensity of vacancy clusters accompanied by the decrease of the intensity of vacancies in the PALS spectra after annealing at 700 K and 800 K can be explained by the formation of vacancy clusters at the expense of single vacancies. This process is driven by the onset of mobility of vacancies and corresponds to recovery stage III. The reduced bulk lifetime τ_1 first decreases after annealing at 550–800 K and then increases at higher temperatures. This indicates that after annealing up to 800 K the total positron trapping rate into the defects, which reflects the total concentration of the defects, increases. Note that for vacancy clusters the trapping rate per missing atom typically decreases with increasing vacancy cluster size [36]. Therefore, the apparent total open volume where the positrons annihilate likely increases after annealing at 500–800 K. This is correlated with the H release from vacancies and vacancy clusters occurring in this temperature range [9, 40, 41, 42]. Above 800 K all trapped H is expected to be removed from the defects and there is no further influence of the presence of H on the thermal evolution of the defects.

The present results show that annealing already at 800 K results in the predominant presence of clusters containing about 20 or more vacancies. A similar result has also been reported by de Vries [14]. The cluster sizes observed after annealing at 700 K and 800 K are larger than the smallest cluster sizes that are still thermally stable at the corresponding temperatures according to theoretical estimations [9, 43] and Kinetic Monte Carlo simulations [44]. The theoretical estimations are based on the assumption

that the cluster thermal dissociation occurs via emission of single vacancies from it (first-order Arrhenius-like process) and are using calculated vacancy binding energies to a cluster as a function of cluster size [43]. This observation can be explained by the fact that cluster coarsening with increasing annealing temperature is influenced not only by the migration and agglomeration of single vacancies (“Ostwald ripening”), but also by the mobility and coalescence of small vacancy clusters [7, 45].

1300-1800 K. After annealing at 1300 K and higher temperatures, the fraction of positrons annihilating in the bulk starts to increase considerably, indicating defect recovery. The longest lifetime increases up to about 600 ps while its intensity decreases. This lifetime is above the theoretical limit of 500 ps described above and may correspond to pick-off annihilation of ortho-positronium formed in large vacancy clusters. This suggests that the internal surfaces of the clusters may be partially decorated with impurities such as O and C [36]. Hu et al. [46] reported the formation of voids with a diameter around 1 nm visible in TEM after post-irradiation annealing at 1273 K of a W single crystal irradiated by fission neutrons to 3×10^{-2} dpa. Therefore, it is possible that in the present experiments further coarsening of vacancy clusters accompanied by the segregation of impurities at their surfaces took place at 1300 K and higher temperatures. This corresponds to the recovery stage V. The intermediate stage (IV) is not pronounced in the present experiments, which means that little changes of open-volume defects occur during it. This stage can correspond to annealing of interstitial-type dislocation loops, as was proposed by Hu et al. [46].

After annealing at 1800 K the lifetime components are the same as in the unirradiated sample, albeit the intensities of the first and second components are somewhat different. This temperature is above the expected operation temperature of W components in the ITER divertor and is also higher than the recrystallization temperature of W [2, 3].

4. Summary

An investigation of the thermal evolution of vacancies and vacancy clusters in single crystalline W in the temperature range 500–1800 K has been carried out. The introduction of predominantly Frenkel pairs as primary defects was done by irradiation with 200 keV H ions to a low damage level (5.8×10^{-3} dpa). The evolution of the sizes and concentrations of the defects was investigated using PALS and DBS techniques.

Substantial changes in the defect structure were observed after post-irradiation annealing at 700 K and were driven by the onset of vacancy mobility, resulting in their agglomeration into clusters containing 10–15 vacancies. Annealing at 800 K and above resulted in the formation of large clusters containing about 20 or more vacancies, a size which cannot be further distinguished by PALS. In the temperature range of 800–1200 K the concentration of open-volume defects practically did not change, whereas at temperatures of 1300 K and above recovery of the defects started and is likely accompanied by a further coarsening of the vacancy clusters. The complete removal of radiation defects was observed after annealing at 1800 K. The determined sizes of the clusters after annealing at 700 K and 800 K were larger than the minimal sizes expected from thermal stability considerations, therefore, it is suggested that the mobility of small vacancy clusters plays an important role in the cluster growth.

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